

1F., Block A of Tongsheng Technology Building, Huahui Road, Dalang Street, Longhua District, Shenzhen, China

Telephone: +86-755-26648640 Fax: +86-755-26648637

Website: www.cqa-cert.com

Report Template Version: V05
Report Template Revision Date: 2021-11-03

Test Report

Report No.: CQASZ20220500889E-01

Applicant: Avantronics Limited

Address of Applicant: The 4th Floor, Yuepeng Building, No.1019 Jiabin Rd, Luohu District, Shenzhen

Equipment Under Test (EUT):

Product: TWS116

Model No.: BTHS-TWS116

Test Model No.: BTHS-TWS116

Brand Name: Avantree

FCC ID: WJ5-BTHS-TWS116

Standards: 47 CFR Part 15, Subpart C

Date of Receipt: 2022-05-25

Date of Test: 2022-05-25 to 2022-06-07

Date of Issue: 2022-06-28
Test Result: PASS*

*In the configuration tested, the EUT complied with the standards specified above.

1. 10 010.

Tested By:	cewis 2hou
	(Lewis Zhou)
	K. Liao

Reviewed By:

(K Liao)

Approved By:

(Jack Ai)







1 Version

Revision History Of Report

Report No.	Version	Description	Issue Date
CQASZ20220500889E-01	Rev.01	Initial report	2022-06-28



2 Test Summary

Test Item	Test Requirement	Test method	Result	
Antenna Requirement	47 CFR Part 15, Subpart C Section 15.203/15.247 (c) ANSI C63.10 (2013)		PASS	
AC Power Line Conducted Emission	47 CFR Part 15, Subpart C Section 15.207	ANSI C63.10 (2013)	PASS	
Conducted Peak Output Power	47 CFR Part 15, Subpart C Section 15.247 (b)(1)	ANSI C63.10 (2013)	PASS	
20dB Occupied Bandwidth	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS	
Carrier Frequencies Separation	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS	
Hopping Channel Number	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS	
Dwell Time	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	ANSI C63.10 (2013)	PASS	
Pseudorandom Frequency Hopping Sequence	47 CFR Part 15, Subpart C Section 15.247(b)(4)	ANSI C63.10 (2013)	PASS	
Band-edge for RF Conducted Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 (2013)	PASS	
RF Conducted Spurious Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	ANSI C63.10 (2013)	PASS	
Radiated Spurious emissions	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 (2013)	PASS	
Restricted bands around fundamental frequency (Radiated Emission)	47 CFR Part 15, Subpart C Section 15.205/15.209	ANSI C63.10 (2013)	PASS	



3 Contents

	Page
1 VERSION	2
2 TEST SUMMARY	3
3 CONTENTS	4
4 GENERAL INFORMATION	5
4.1 CLIENT INFORMATION	5
4.2 GENERAL DESCRIPTION OF EUT	
4.3 ADDITIONAL INSTRUCTIONS	7
4.4 TEST ENVIRONMENT	
4.5 DESCRIPTION OF SUPPORT UNITS	
4.6 STATEMENT OF THE MEASUREMENT UNCERTAINTY	
4.7 TEST LOCATION	
4.8 TEST FACILITY	
4.9 ABNORMALITIES FROM STANDARD CONDITIONS	
4.11 EQUIPMENT LIST	
5 TEST RESULTS AND MEASUREMENT DATA	12
5.1 Antenna Requirement	12
5.2 CONDUCTED EMISSIONS	
5.3 CONDUCTED PEAK OUTPUT POWER	17
5.4 20DB OCCUPY BANDWIDTH	
5.5 CARRIER FREQUENCIES SEPARATION	
5.6 HOPPING CHANNEL NUMBER	
5.7 DWELL TIME	
5.8 BAND-EDGE FOR RF CONDUCTED EMISSIONS	
5.10 OTHER REQUIREMENTS FREQUENCY HOPPING SPREAD SPECTRUM SYSTEM	
5.11 RADIATED SPURIOUS EMISSION & RESTRICTED BANDS	
5.11.1 Radiated Emission below 1GHz	
5.11.2 Transmitter Emission above 1GHz	
6 PHOTOGRAPHS - EUT TEST SETUP	81
6.1 RADIATED EMISSION	81
6.2 CONDUCTED EMISSION	82
7 DUOTOGRADUS EUT CONSTRUCTIONAL DETAILS	92



Report No.: CQASZ20220500889E-01

4 General Information

4.1 Client Information

Applicant:	Avantronics Limited		
Address of Applicant:	The 4th Floor, Yuepeng Building, No.1019 Jiabin Rd, Luohu District, Shenzhen		
Manufacturer:	Avantronics Limited		
Address of Manufacturer:	The 4th Floor, Yuepeng Building, No.1019 Jiabin Rd, Luohu District, Shenzhen		
Factory:	Avantronics Limited		
Address of Factory:	The 4th Floor, Yuepeng Building, No.1019 Jiabin Rd, Luohu District, Shenzhen		

4.2 General Description of EUT

Product Name:	TWS116
Model No.:	BTHS-TWS116
Test Model No.:	BTHS-TWS116
Trade Mark:	Avantree
Software Version:	Avantree TWS116-1703-A1
Hardware Version:	H1-1703 -V02
Operation Frequency:	2402MHz~2480MHz
Bluetooth Version:	V5.0
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type:	GFSK, π/4DQPSK, 8DPSK
Transfer Rate:	1Mbps/2Mbps/3Mbps
Number of Channel:	79
Hopping Channel Type:	Adaptive Frequency Hopping systems
Product Type:	☐ Mobile ☐ Portable ☐ Fix Location
Test Software of EUT:	AWRDLABV2(1.0.9.22)
Antenna Type:	Chip antenna
Antenna Gain:	2dBi
Power Supply:	earphone: 3.7V 110mAh 0.407Wh
	charging compartment: 3.7V 2200mAh 8.14Wh, Charge by DC 5V for adapter



Report No.: CQASZ20220500889E-01

Operation F	Operation Frequency each of channel						
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz
2	2404MHz	22	2424MHz	42	2444MHz	62	2464MHz
3	2405MHz	23	2425MHz	43	2445MHz	63	2465MHz
4	2406MHz	24	2426MHz	44	2446MHz	64	2466MHz
5	2407MHz	25	2427MHz	45	2447MHz	65	2467MHz
6	2408MHz	26	2428MHz	46	2448MHz	66	2468MHz
7	2409MHz	27	2429MHz	47	2449MHz	67	2469MHz
8	2410MHz	28	2430MHz	48	2450MHz	68	2470MHz
9	2411MHz	29	2431MHz	49	2451MHz	69	2471MHz
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
12	2414MHz	32	2434MHz	52	2454MHz	72	2474MHz
13	2415MHz	33	2435MHz	53	2455MHz	73	2475MHz
14	2416MHz	34	2436MHz	54	2456MHz	74	2476MHz
15	2417MHz	35	2437MHz	55	2457MHz	75	2477MHz
16	2418MHz	36	2438MHz	56	2458MHz	76	2478MHz
17	2419MHz	37	2439MHz	57	2459MHz	77	2479MHz
18	2420MHz	38	2440MHz	58	2460MHz	78	2480MHz
19	2421MHz	39	2441MHz	59	2461MHz		

Note:

In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

<u> </u>	_
Channel	Frequency
The Lowest channel	2402MHz
The Middle channel	2441MHz
The Highest channel	2480MHz

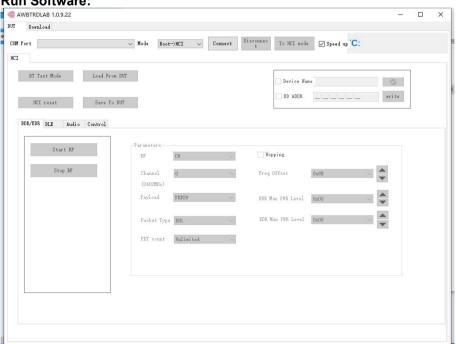




4.3 Additional Instructions

EUT Test Software Settings:				
Mode:	 ⊠ Special software is used. ☐ Through engineering command into the engineering mode. engineering command: *#*#3646633#*#* 			
EUT Power level:	Class2 (Power level is built-in set pa selected)	Class2 (Power level is built-in set parameters and cannot be changed and selected)		
Use test software to set the	lowest frequency, the middle frequency a	nd the highest frequency keep		
transmitting of the EUT.				
Mode	Channel Frequency(MHz)			
	CH0	2402		
DH1/DH3/DH5	CH39	2441		
	CH78	2480		
	CH0	2402		
2DH1/2DH3/2DH5	CH39	2441		
	CH78	2480		
	CH0	2402		
3DH1/3DH3/3DH5	CH39	2441		
	CH78	2480		

Run Software:





Report No.: CQASZ20220500889E-01

4.4 Test Environment

Operating Environment:	Operating Environment:			
Temperature:	25 °C			
Humidity:	54% RH			
Atmospheric Pressure:	1009mbar			
Test Mode:	Use test software to set the lowest frequency, the middle frequency and the highest frequency keep transmitting of the EUT.			

4.5 Description of Support Units

The EUT has been tested with associated equipment below.

Description	Manufacturer	Model No.	Remark	FCC certification
Adapter	MI	1	/	CQA





4.6 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate.

The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities.

The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements" and is documented in the **Shenzhen Huaxia Testing Technology Co., Ltd.** guality system acc. to DIN EN ISO/IEC 17025.

Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CQA laboratory is reported:

No.	Item	Uncertainty
1	Radiated Emission (Below 1GHz)	5.12dB
2	Radiated Emission (Above 1GHz)	4.60dB
3	Conducted Disturbance (0.15~30MHz)	3.34dB
4	Radio Frequency	3×10 ⁻⁸
5	Duty cycle	0.6 %
6	Occupied Bandwidth	1.1%
7	RF conducted power	0.86dB
8	RF power density	0.74
9	Conducted Spurious emissions	0.86dB
10	Temperature test	0.8℃
11	Humidity test	2.0%
12	Supply voltages	0.5 %
13	Frequency Error	5.5 Hz



Report No.: CQASZ20220500889E-01

4.7 Test Location

All tests were performed at:

Shenzhen Huaxia Testing Technology Co., Ltd.

1F., Block A of Tongsheng Technology Building, Huahui Road, Dalang Street, Longhua District, Shenzhen, China

4.8 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

IC Registration No.: 22984-1

The 3m Semi-anechoic chamber of Shenzhen Huaxia Testing Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L5785)

CNAS has accredited Shenzhen Huaxia Testing Technology Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 4742.01)

Shenzhen Huaxia Testing Technology Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 4742.01.

• FCC Registration No.: 522263

Shenzhen Huaxia Testing Technology Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.:522263

4.9 Abnormalities from Standard Conditions

None.

4.10 Other Information Requested by the Customer

None.





4.11 Equipment List

			Instrument	Calibration	Calibration
Test Equipment	Manufacturer	Model No.	No.	Date	Due Date
EMI Test Receiver	R&S	ESR7	CQA-005	2021/9/10	2022/9/9
Spectrum analyzer	R&S	FSU26	CQA-038	2021/9/10	2022/9/9
		AFS4-00010300-18-10P-			
Preamplifier	MITEQ	4	CQA-035	2021/9/10	2022/9/9
		AMF-6D-02001800-29-			
Preamplifier	MITEQ	20P	CQA-036	2021/9/10	2022/9/9
Loop antenna	Schwarzbeck	FMZB1516	CQA-087	2021/9/16	2024/9/15
Bilog Antenna	R&S	HL562	CQA-011	2021/9/16	2024/9/15
Horn Antenna	R&S	HF906	CQA-012	2021/9/16	2024/9/15
Horn Antenna	Schwarzbeck	BBHA 9170	CQA-088	2021/9/16	2024/9/15
Coaxial Cable					
(Above 1GHz)	CQA	N/A	C019	2021/9/10	2022/9/9
Coaxial Cable					
(Below 1GHz)	CQA	N/A	C020	2021/9/10	2022/9/9
Antenna Connector	CQA	RFC-01	CQA-080	2021/9/10	2022/9/9
RF					
cable(9KHz~40GHz)	CQA	RF-01	CQA-079	2021/9/10	2022/9/9
Power divider	MIDWEST	PWD-2533-02-SMA-79	CQA-067	2021/9/10	2022/9/9
EMI Test Receiver	R&S	ESPI3	CQA-013	2021/9/10	2022/9/9
LISN	R&S	ENV216	CQA-003	2021/9/10	2022/9/9
Coaxial cable	CQA	N/A	CQA-C009	2021/9/10	2022/9/9

Note:

The temporary antenna connector is soldered on the PCB board in order to perform conducted tests and this temporary antenna connector is listed in the equipment list.



Report No.: CQASZ20220500889E-01

5 Test results and Measurement Data

5.1 Antenna Requirement

Standard requirement: 47 CFR Part 15C Section 15.203 /247(c)

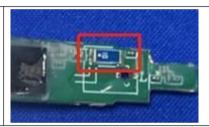
15.203 requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

15.247(b) (4) requirement:

The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

EUT Antenna:



The antenna is Chip antenna. The best case gain of the antenna is 2 dBi.





5.2 Conducted Emissions

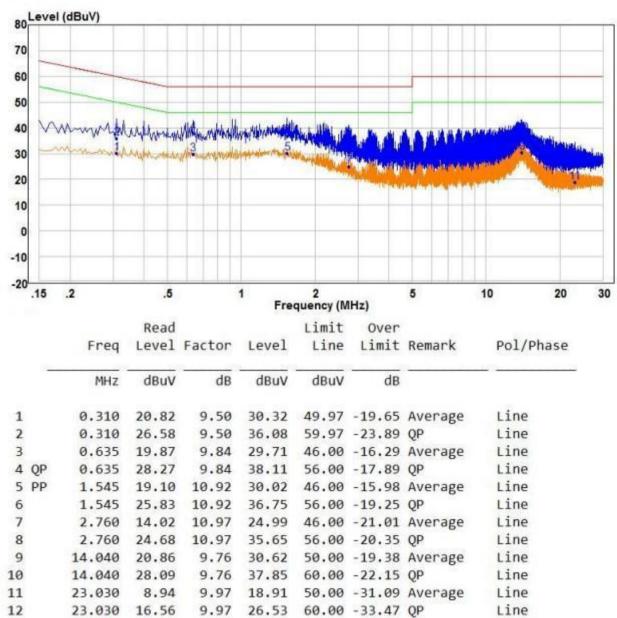
Test Requirement:	47 CFR Part 15C Section 15.207			
Test Method:	ANSI C63.10: 2013			
Test Frequency Range:	: 150kHz to 30MHz			
Limit:	Frequency range (MHz)	Limit (d	Limit (dBuV)	
	Frequency range (MHZ)	Quasi-peak	Average	
	0.15-0.5	66 to 56*	56 to 46*	
	0.5-5	56	46	
	5-30	60	50	
	* Decreases with the logarithn	n of the frequency.		
Test Procedure:	 Decreases with the logarithm of the frequency. The mains terminal disturbance voltage test was conducted in a shielded room. The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a 50Ω/50μH + 5Ω linear impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multiple power cables to a single LISN provided the rating of the LISN was not exceeded. The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0.4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN 1 was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISNs mounted on top of the ground reference plane. This distance was between the closest points of the LISN 1 and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the LISN 2. In order to find the maximum emission, the relative positions of 			
Test Setup:	ANSI C63.10: 2013 on con	ducted measurement.		
. Sol College	Shielding Room EUT AC Mains LISN1	AE LISN2 AC Main Ground Reference Plane	Test Receiver	



Exploratory Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type at the lowest, middle, high channel.
Final Test Mode:	Through Pre-scan, find the DH5 of data type and GFSK modulation at the lowest channel is the worst case. Only the worst case is recorded in the report.
Test Voltage:	AC 120V/60Hz
Test Results:	Pass

Measurement Data

Live line:

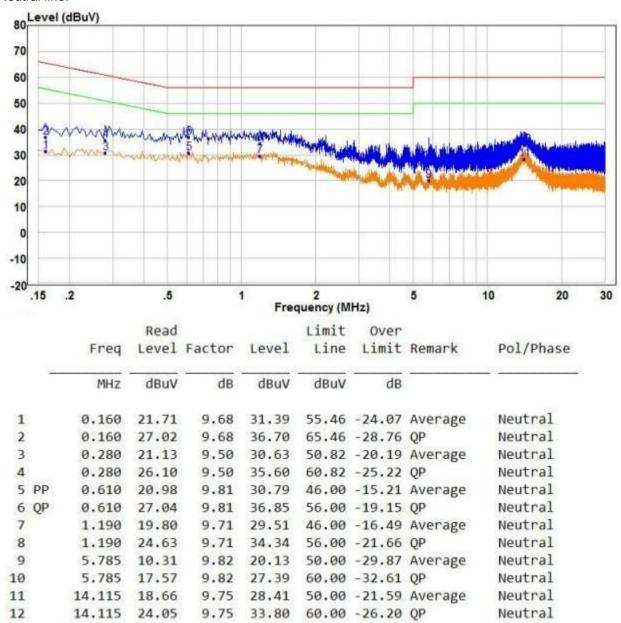


Remark:

- 1. The following Quasi-Peak and Average measurements were performed on the EUT:
- 2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.
- 3. If the Peak value under Average limit, the Average value is not recorded in the report.



Neutral line:



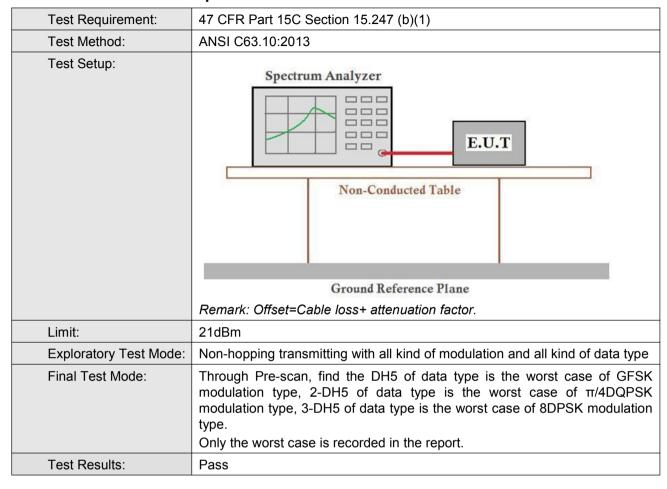
Remark:

- 1. The following Quasi-Peak and Average measurements were performed on the EUT:
- 2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.
- 3. If the Peak value under Average limit, the Average value is not recorded in the report.



Report No.: CQASZ20220500889E-01

5.3 Conducted Peak Output Power





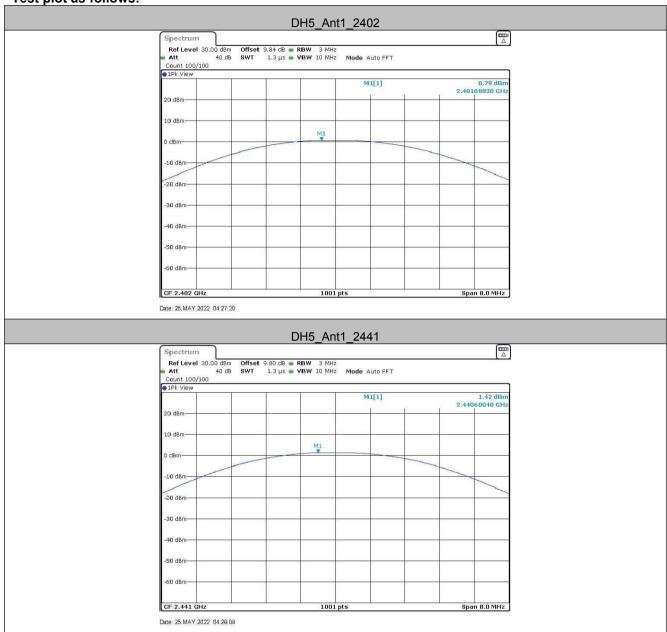
Report No.: CQASZ20220500889E-01

Measurement Data

GFSK mode					
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result		
Lowest	0.79	21.00	Pass		
Middle	1.42	21.00	Pass		
Highest	2.09	21.00	Pass		
	π/4DQPSK mo	ode			
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result		
Lowest	1.27	21.00	Pass		
Middle	1.91	21.00	Pass		
Highest	2.72	21.00	Pass		
	8DPSK mode				
Test channel	Peak Output Power (dBm)	Limit (dBm)	Result		
Lowest	1.94	21.00	Pass		
Middle	2.54	21.00	Pass		
Highest	3.36	21.00	Pass		











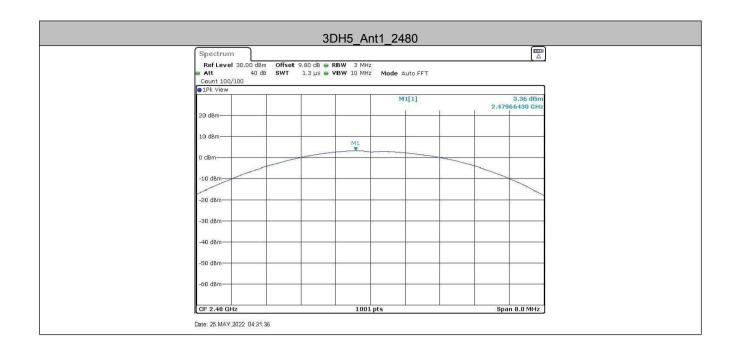








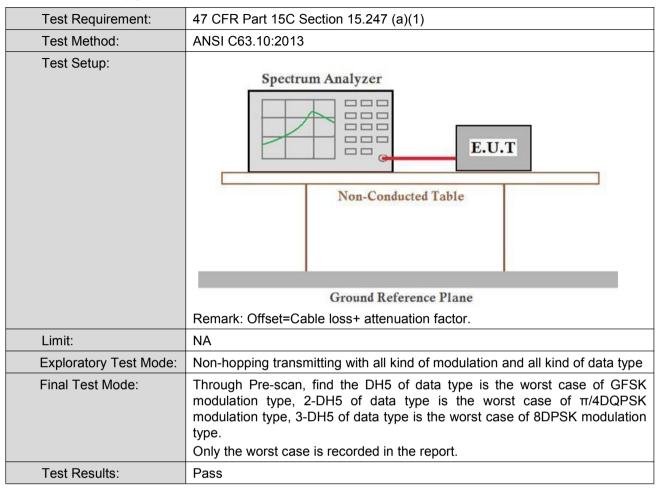








5.4 20dB Occupy Bandwidth



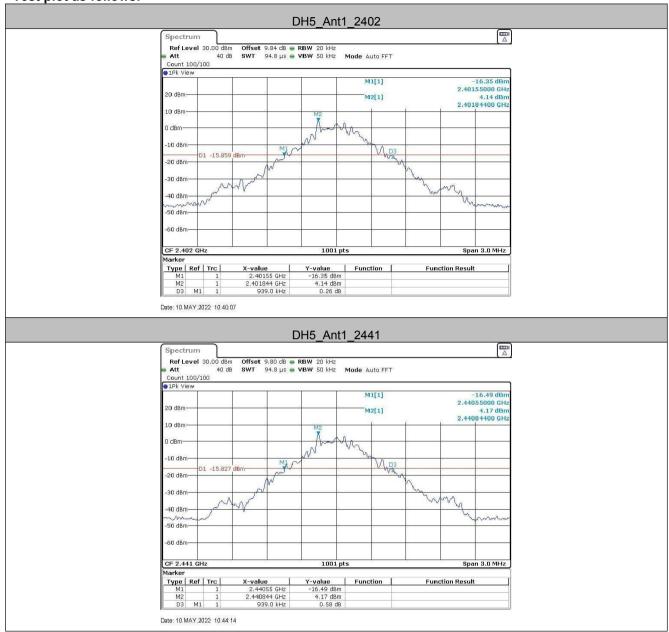
Measurement Data

	20dB Occupy Bandwidth (MHz)			
Test channel	GFSK	π/4DQPSK	8DPSK	
Lowest	0.939	1.239	1.239	
Middle	0.939	1.236	1.236	
Highest	0.942	1.236	1.236	



Report No.: CQASZ20220500889E-01

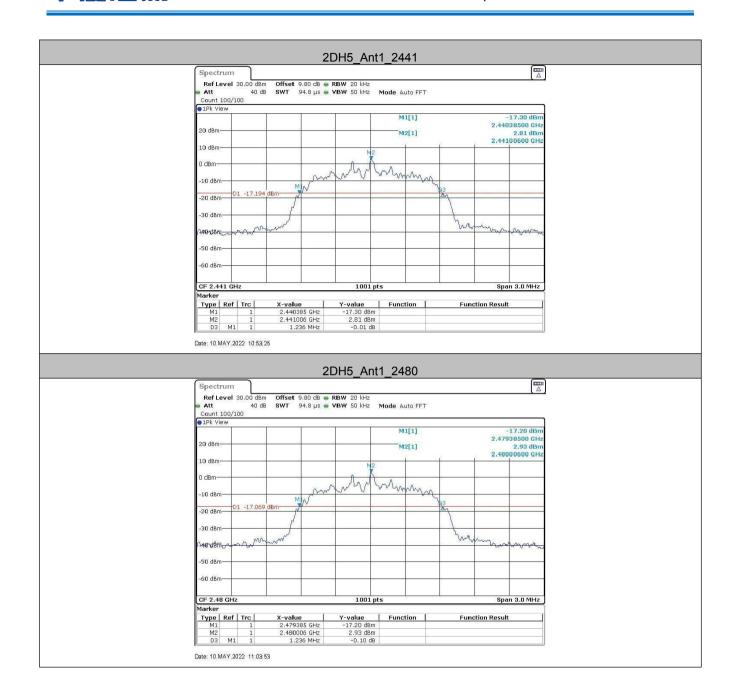
Test plot as follows:







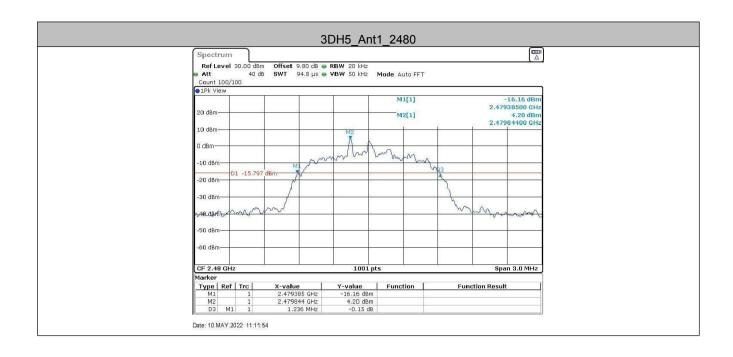








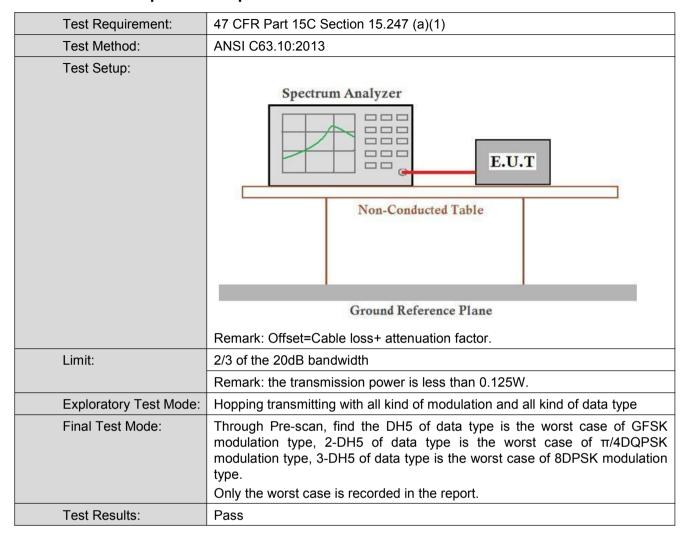








5.5 Carrier Frequencies Separation





Report No.: CQASZ20220500889E-01

Measurement Data

TestMode	Antenna	Channel	Result[MHz]	Limit[MHz]	Verdict
DH5	Ant1	Нор	1.003	≥0.628	PASS
2DH5	Ant1	Нор	1.325	≥0.826	PASS
3DH5	Ant1	Нор	1.336	≥0.826	PASS

Mode	20dB bandwidth (MHz) (worse case)	Limit (MHz) (Carrier Frequencies Separation)	
GFSK	0.942	≥0.628	
π/4DQPSK	1.239	≥0.826	
8DPSK	1.239	≥0.826	

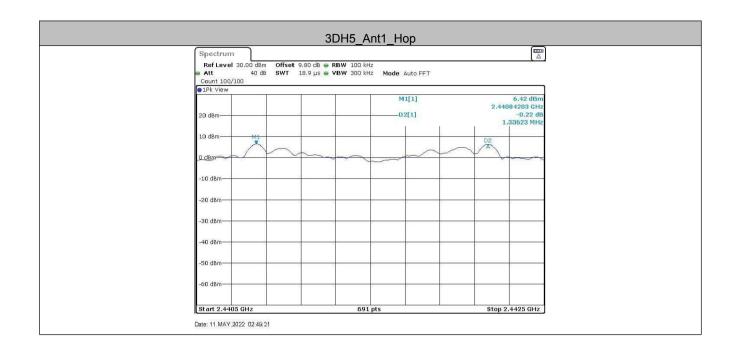


Report No.: CQASZ20220500889E-01

Test plot as follows:



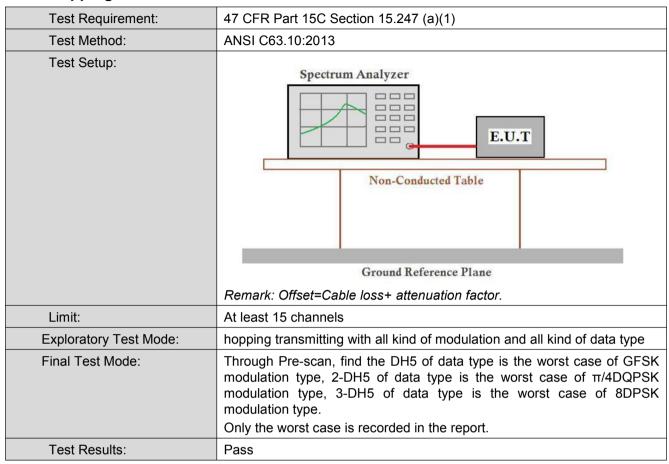






Report No.: CQASZ20220500889E-01

5.6 Hopping Channel Number

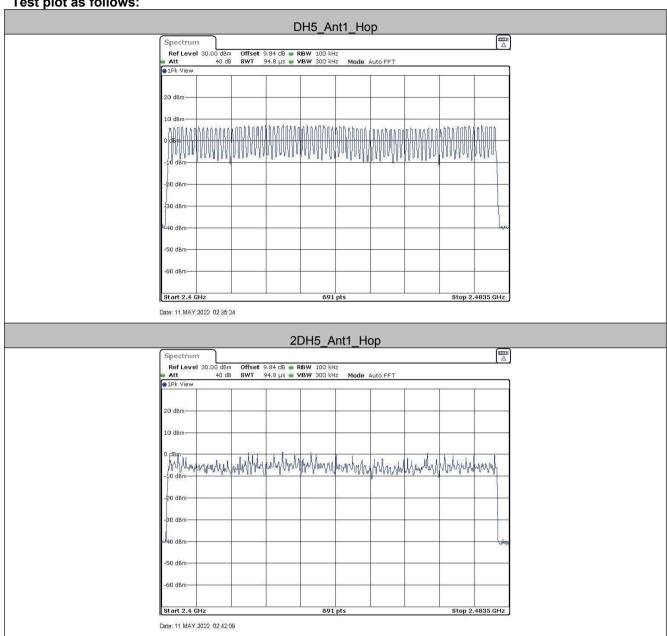


Measurement Data

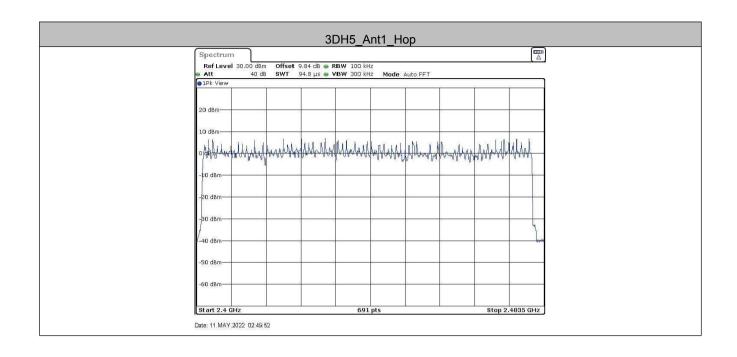
Mode	Hopping channel numbers	Limit
GFSK	79	≥15
π/4DQPSK	79	≥15
8DPSK	79	≥15







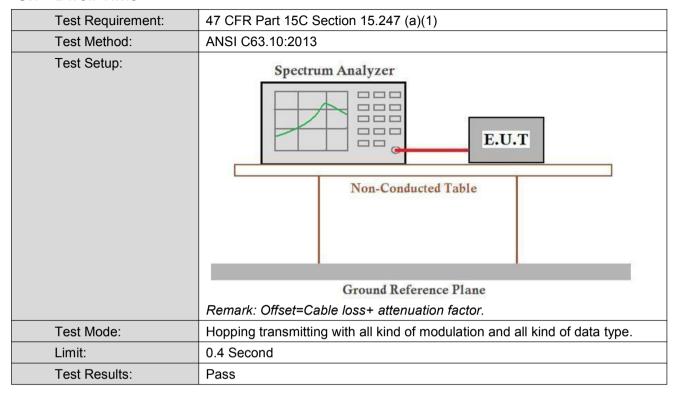








5.7 Dwell Time







Measurement Data

TestMode	Antenna	Channel	BurstWidth [ms]	TotalHops [Num]	Result[s]	Limit[s]	Verdict
DH1	Ant1	Нор	0.37	330	0.122	≤0.4	PASS
DH3	Ant1	Нор	1.61	170	0.274	≤0.4	PASS
DH5	Ant1	Нор	2.85	110	0.314	≤0.4	PASS
2DH1	Ant1	Нор	0.38	330	0.124	≤0.4	PASS
2DH3	Ant1	Нор	1.62	160	0.259	≤0.4	PASS
2DH5	Ant1	Нор	2.86	110	0.315	≤0.4	PASS
3DH1	Ant1	Нор	0.38	330	0.125	≤0.4	PASS
3DH3	Ant1	Нор	1.62	160	0.259	≤0.4	PASS
3DH5	Ant1	Нор	2.86	110	0.315	≤0.4	PASS

Remark:

The test period: T= 0.4 Second/Channel x 79 Channel = 31.6 s

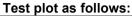
DH1/2DH1/3DH1 Dwell time = Burst Width(ms)*[1600/ (2*79)]*31.6

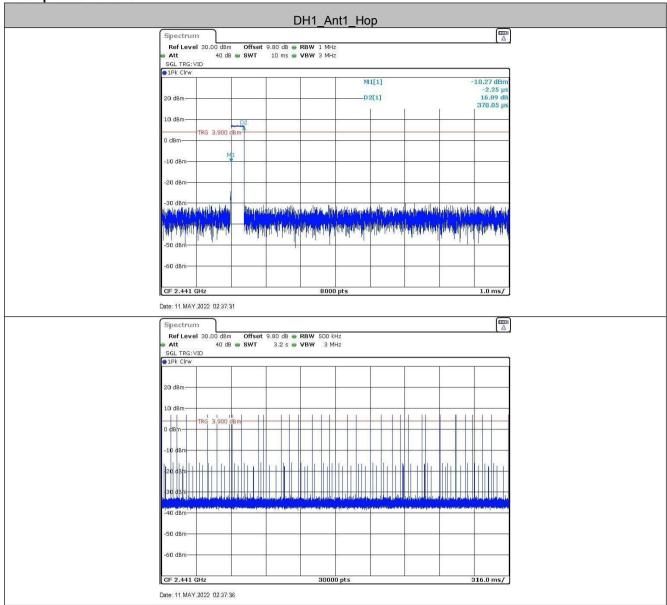
DH3/2DH3/3DH3 Dwell time = Burst Width (ms)*[1600/ (4*79)]*31.6

DH5/2DH5/3DH5 Dwell time = Burst Width (ms)*[1600/ (6*79)]*31.6

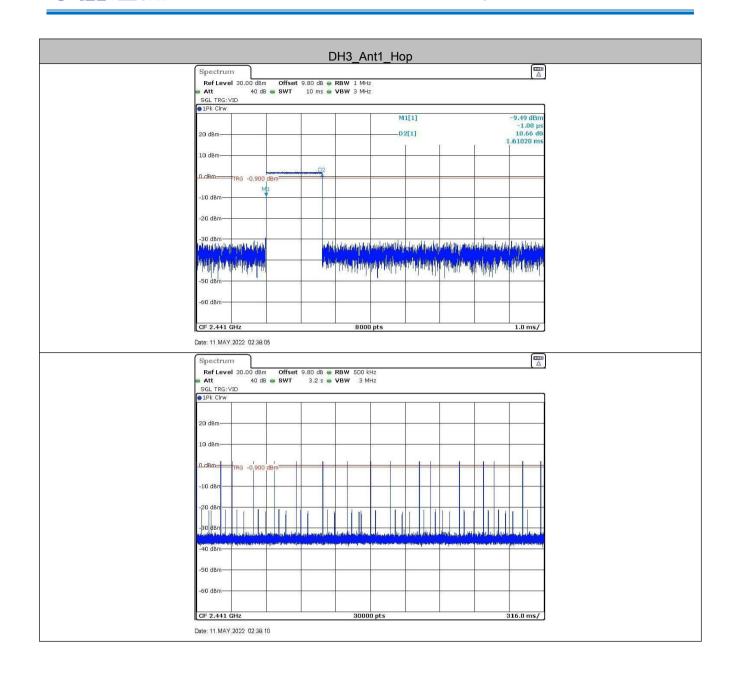




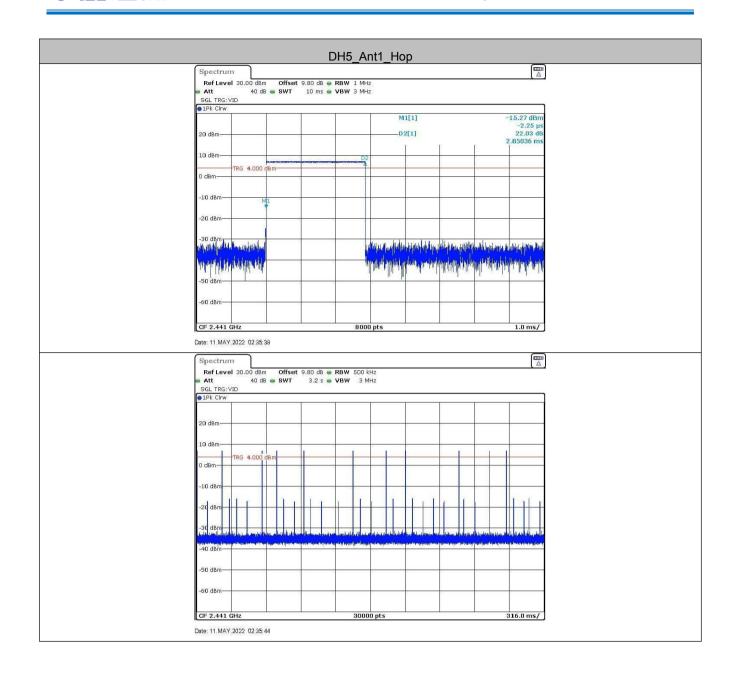




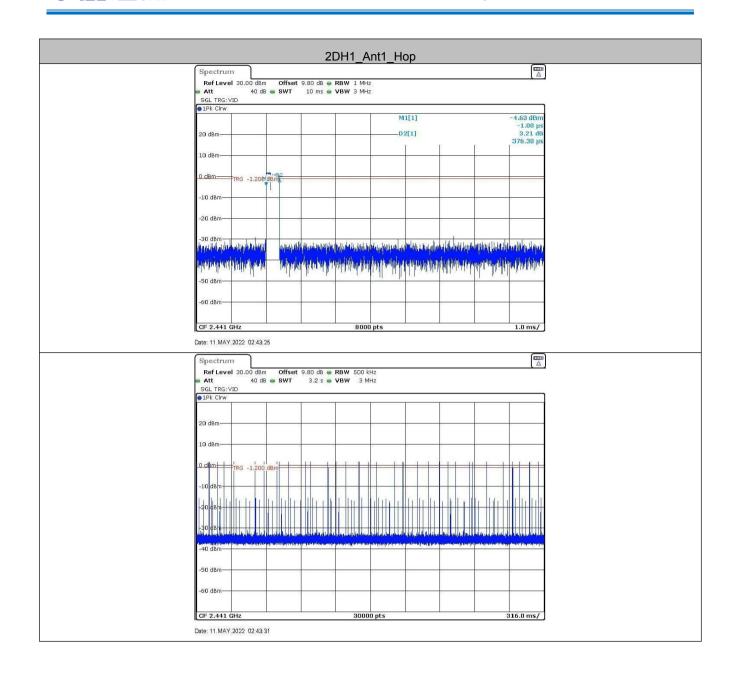




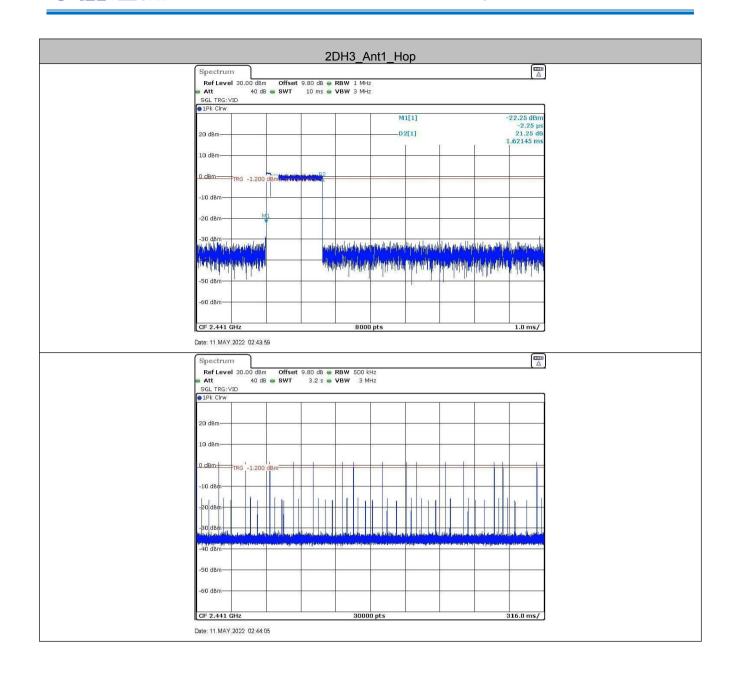




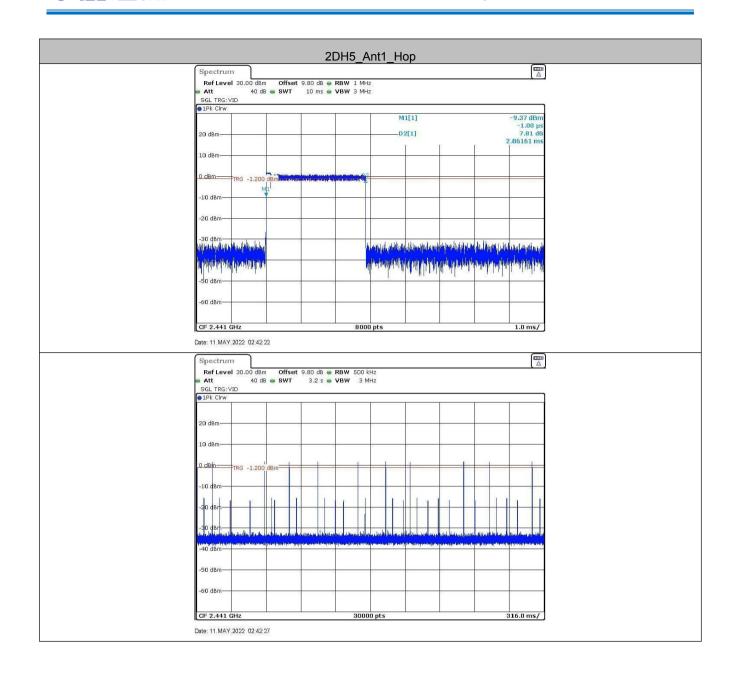




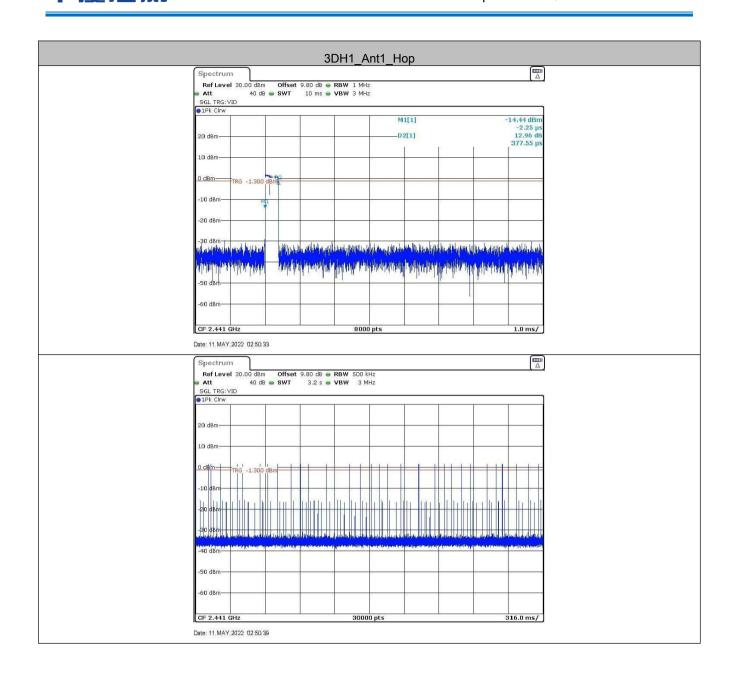




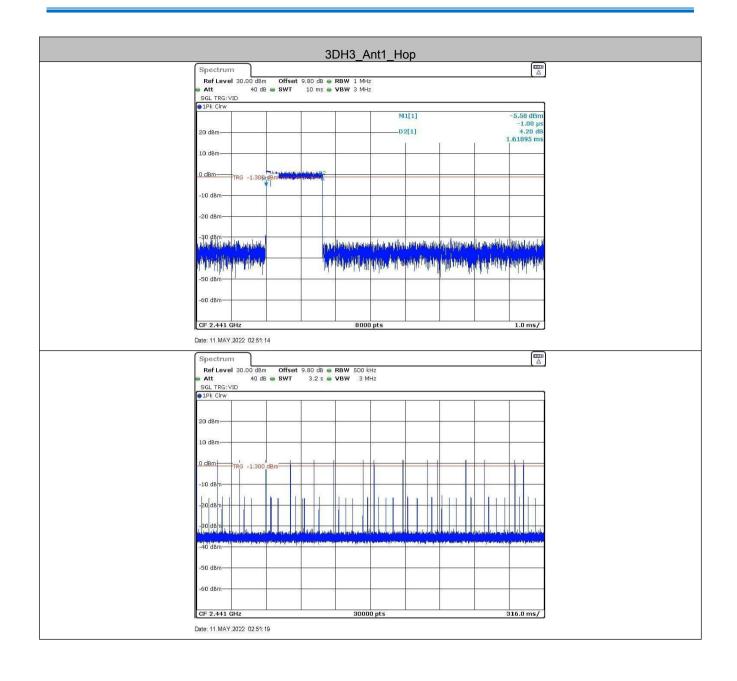




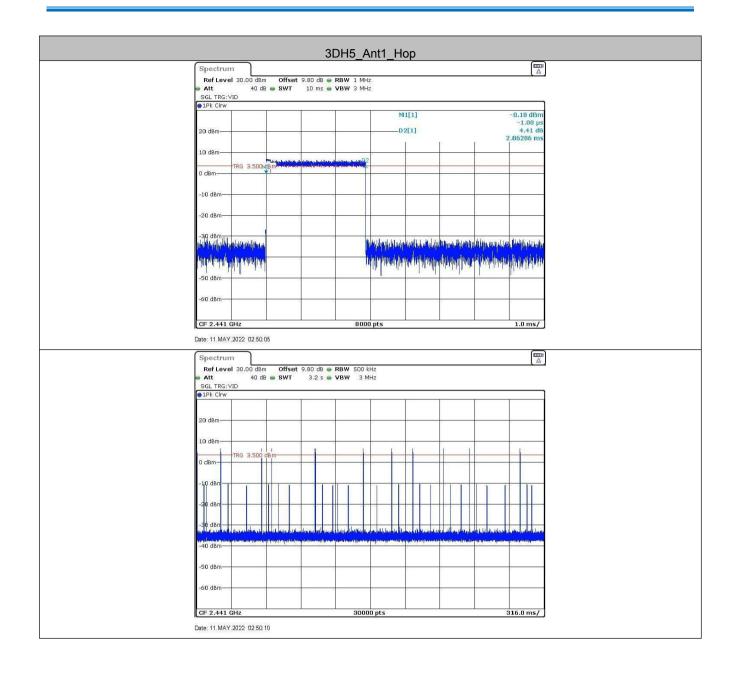
















5.8 Band-edge for RF Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.247 (d)	
Test Method:	ANSI C63.10:2013	
Test Setup:	Spectrum Analyzer E.U.T Non-Conducted Table	
	Ground Reference Plane Remark: Offset=cable loss+ attenuation factor.	
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.	
Exploratory Test Mode:	Hopping and Non-hopping transmitting with all kind of modulation and all kind of data type	
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of $\pi/4DQPSK$ modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type. Only the worst case is recorded in the report.	
Test Results:	Pass	

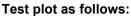


Report No.: CQASZ20220500889E-01

Measurement Data

TestMode	Antenna	ChName	Channel	RefLevel	Result [dBm]	Limit [dBm]	Verdict
DH5	Ant1	Low	2402	6.57	-46.46	≤-13.43	PASS
		High	2480	6.63	-45.87	≤-13.37	PASS
		Low	Hop_2402	1.38	-48.57	≤-18.62	PASS
		High	Hop_2480	1.26	-47.16	≤-18.74	PASS
2DH5	Ant1	Low	2402	5.92	-43.68	≤-14.08	PASS
		High	2480	5.89	-47.53	≤-14.11	PASS
		Low	Hop 2402	1.74	-48.6	≤-18.26	PASS
		High	Hop 2480	5.28	-47.03	≤-14.72	PASS
3DH5	Ant1	Low	2402	6.63	-44.81	≤-13.37	PASS
		High	2480	6.67	-47.79	≤-13.33	PASS
		Low	Hop_2402	2.14	-48.52	≤-17.86	PASS
		High	Hop_2480	1.02	-48.01	≤-18.98	PASS



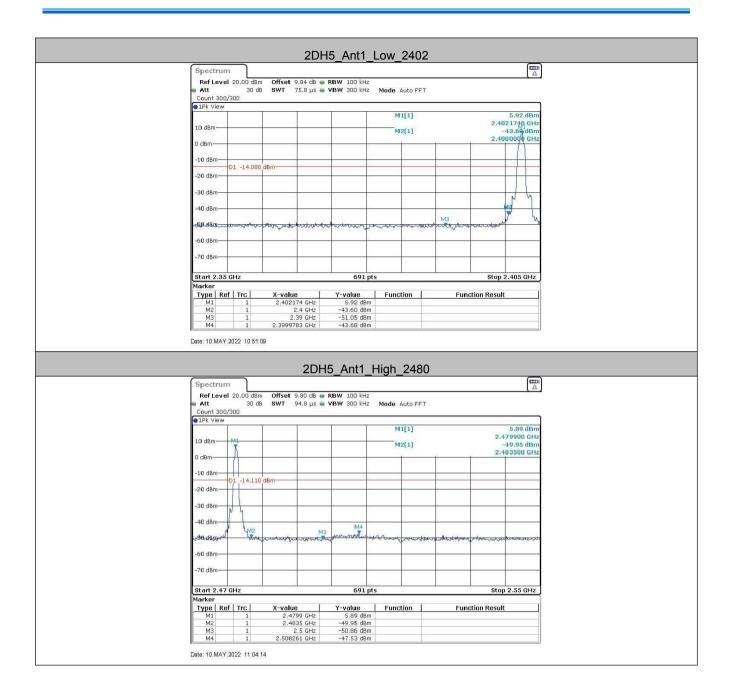




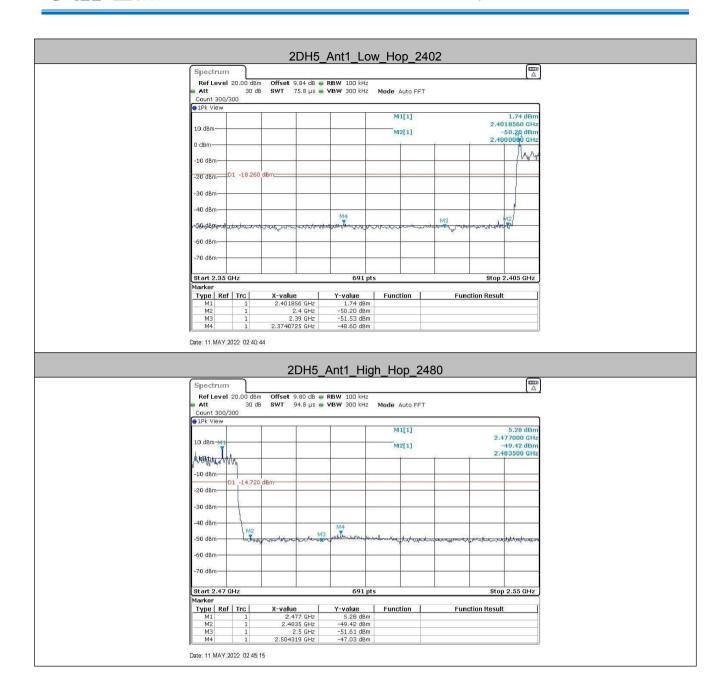




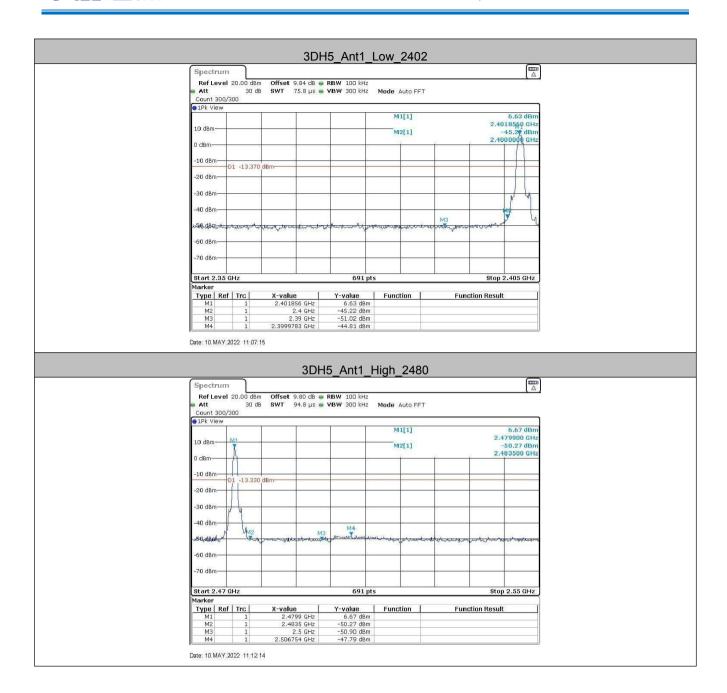


















Report No.: CQASZ20220500889E-01

5.9 Spurious RF Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.247 (d)		
Test Method:	ANSI C63.10:2013		
Test Setup:	Spectrum Analyzer E.U.T Non-Conducted Table Ground Reference Plane		
	Remark: Offset=cable loss+ attenuation factor.		
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.		
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type		
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSk modulation type, 2-DH5 of data type is the worst case of $\pi/4DQPSk$ modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.		
Test Results:	Pass		





